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# User's Guide

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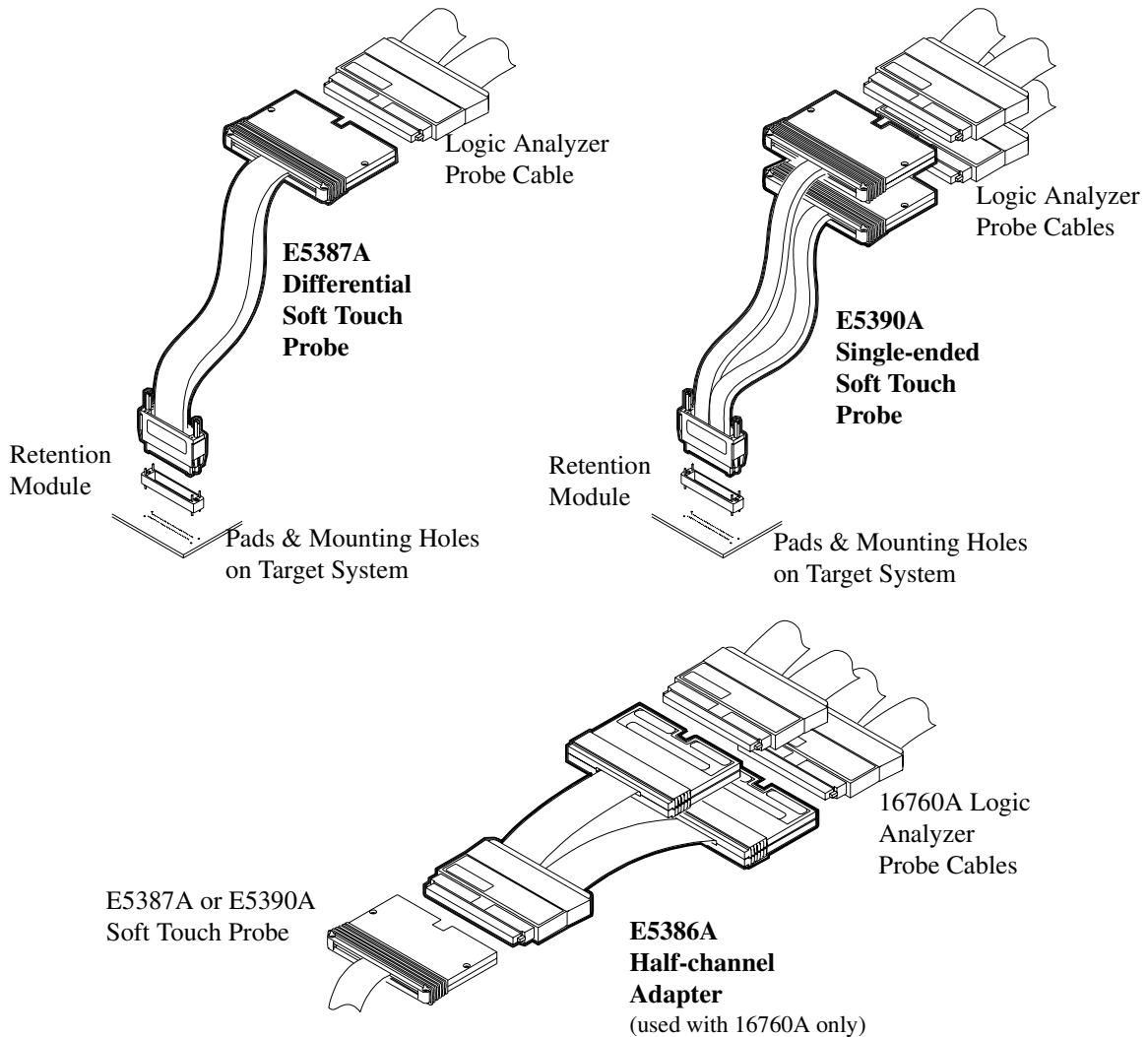
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Agilent Technologies  
Soft Touch Connector-less Probes  
for 1675x/1676x Logic Analyzers  
(E5387A and E5390A)

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## The Soft Touch Probes— At a Glance

The new Agilent soft touch probes are ultra-low-load connector-less probes that work with the Agilent 16753A, 16754A, 16755A, 16756A, and 16760A logic analysis modules. The E5387A is a 17-channel differential soft-touch probe and the E5390A is a 34-channel single-ended soft-touch probe. The probes attach to the PC board using a retention module which ensures pin-to-pad alignment and holds the probe in place. The E5386A adapter works with the soft touch probes in half-channel state mode on the 16760A logic analyzer.



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## In This Book

In this book, you will find information that helps you understand and implement the high-bandwidth, high-density, soft-touch probing solutions available with the Agilent 16753A, 16754A, 16755A, 16756A and 16760A high speed logic analyzers. Use this information to both evaluate the electrical and mechanical implications to your target system's design, and to properly layout the target system to connect to the logic analyzer.

Chapter 1 provides a description of the soft touch probes and tables to help determine which probe to use.

Chapter 2 covers the mechanical considerations, footprint for PC board layout, and probe/retention module dimensions.

Chapter 3 provides operation information including electrical considerations such as equivalent probe loads, input impedance, time domain transmission (TDT), step response, and eye opening.

Chapter 4 provides design considerations for layout of your circuit board.

Chapter 5 offers a list of recommended reading for additional information.

Chapter 6 lists orderable parts.



## **1 Probing Options 9**

Introduction to Probing Options	10
The E5387A Differential Soft Touch Probe (for analyzers with 90-pin pod connectors)	11
The E5390A Single-ended Soft Touch Probe (for analyzers with 90-pin pod connectors)	12
The E5386A Half-channel Adapter (for use with the 16760A logic analyzer)	13

## **2 Mechanical Considerations 15**

E5387A and E5390A Soft Touch Probe Specifications	16
Probe Dimensions	16
Retention Module Dimensions	17
Probe and Retention Module Dimensions	17
Probe footprint dimensions	18
Pin out for the E5387A differential soft touch	19
Pin out for the E5390A single-ended soft touch probe	21
E5386A Half-channel Adapter	23
E5386A used with E5387A Pin-out Table	24
E5386A used with E5390A Pin-out Table	25

## **3 Operating the Probe 27**

Equivalent Probe Loads	28
------------------------	----

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# Contents

E5387A and E5390A probe load model	28
Measured versus modeled input impedance	29
Time Domain Transmission (TDT)	30
Step Inputs	33
Eye Opening	36

## **4 Circuit Board Design** 39

Transmission Line Considerations	40
Recommended Routing	41
Agilent E5387A 17-bit routing	41
Agilent E5390A 34-bit routing	42
Data and Clock Inputs per Operating Mode	43
16760A logic analyzer	43
16753/54/55/56A logic analyzers	44
Thresholds	45
E5387A differential soft touch probe	45
Data inputs	45
Clock input	45
E5390A single-ended soft touch probe	45
Data inputs	45
Clock input	46
Signal Access	47
Labels split across probes	47
Reordered bits	47
Half-channel 1.25 and 1.5 Gb/s modes (16760A only)	48

**5 Recommended Reading 49**

For More Information 50

MECL System Design Handbook 50

High-speed Digital Design 50

Designing High-speed Target Systems for Logic Analyzer Probing 50

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# Contents



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**Probing Options**

## Introduction to Probing Options

This chapter provides descriptions of the logic analyzer probes and adapters to help you select the appropriate probe for your application.

### Number of Probes Required

This table shows how many probes are required to provide connections to all channels of your logic analyzer module.

Probe	Logic Analyzer Module	
	16760A	16753A, 16754A, 16755A, 16756A
E5387A differential soft touch probe	2	4
E5390A single-ended soft touch probe	1	2

### Maximum State Speed Supported

This table gives you the maximum state speed that is supported by the combination of a probe and your logic analyzer module.

Probe	Logic Analyzer Module	
	16760A	16753A, 16754A, 16755A, 16756A
E5387A differential soft touch probe	1.5 Gb/s	600 MHz
E5390A single-ended soft touch probe	1.5 Gb/s	600 MHz

### Retention Modules

A kit of five retention modules are supplied with each E5387A and E5390A probe. Additional kits can be ordered using Agilent part number E5387-68701. If large quantities of retention modules are needed, please contact Precision Interconnect at 10025 SW Freeman Court, Wilsonville, OR 97070, <http://www.precisionint.com/>, 1-503-685-9300. Order part number 600-0118-01.

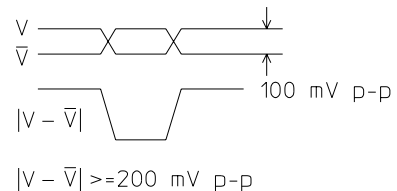
## The E5387A Differential Soft Touch Probe (for analyzers with 90-pin pod connectors)

The Agilent E5387A is a 17-channel, differential, soft touch probe compatible with the Agilent 16753A, 16754A, 16755A, 16756A, and 16760A logic analysis modules. It is capable of capturing data up to the rated maximum state (synchronous) analysis clock rates of all the supported analyzers, with differential signal amplitudes as small as 200 mV peak-to-peak (100 mV peak-to-peak on both positive and negative inputs). A retention module must be installed on the target system board to attach the probe to the board.

A kit of five retention modules are supplied with each E5387A probe. Additional kits can be ordered using Agilent part number E5387-68701.

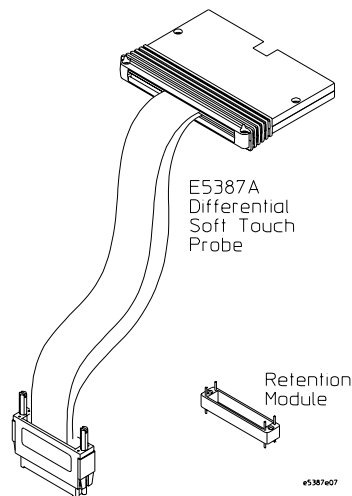
### Differential Input Amplitude

**Definition.** For differential signals, the difference voltage  $V - \bar{V}$  must be greater than or equal to 200 mV p-p.



### See Also

Chapter 2 for the mechanical information to design your target system board.



### E5387A differential soft touch probe and retention module

**The E5390A Single-ended Soft Touch Probe (for analyzers with 90-pin pod connectors)**

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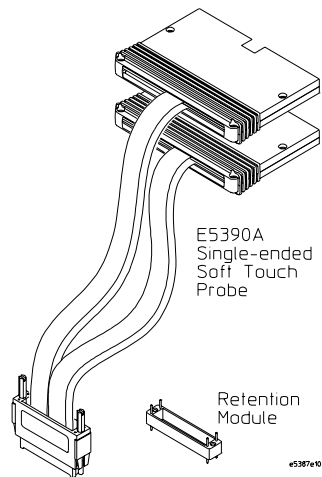
## The E5390A Single-ended Soft Touch Probe (for analyzers with 90-pin pod connectors)

The Agilent E5390A is a 34-channel, single-ended, soft touch probe compatible with the Agilent 16753A, 16754A, 16755A, 16756A, and 16760A logic analysis modules. It is capable of capturing data up to the rated maximum state (synchronous) analysis clock rates of all the supported analyzers, with signal amplitudes as small as 250 mV peak-to-peak. A retention module must be installed on the target system board to attach the probe to the board.

A kit of five retention moduls are supplied with each E5390A probe. Additional kits can be ordered using Agilent part number E5387-68701.

**See Also**

Chapter 2 for the mechanical information to design your target system board.

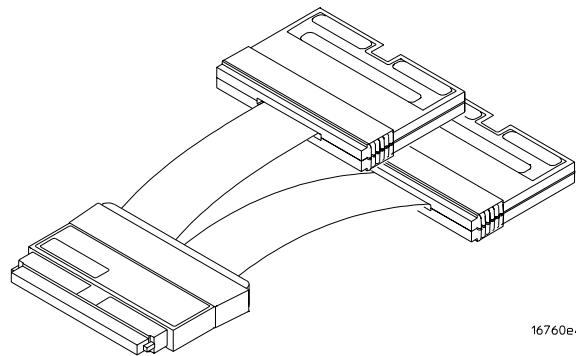


**E5390A single-ended soft touch probe and retention module**

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## The E5386A Half-channel Adapter (for use with the 16760A logic analyzer)

The E5386A Half-channel Adapter is intended to be used with the Agilent 16760A logic analyzer in half-channel state mode. It supports both the E5387A differential soft touch probe and the E5390A single-ended soft touch probe.



The E5386A Half-channel Adapter has its own ID code. When using the adapter, the 16760A logic analyzer recognizes its code rather than that of the probe which is attached to the target. Therefore, the user interface format menu doesn't automatically set thresholds to the right values. You need to go into the threshold menu and select (differential, custom, or standard settings).

When using the adapter in half-channel state mode:

- Clock-bits are not available in half-channel state mode (although JCLK on the master is still used).
- Be sure to connect Master pod 1 of the logic analyzer to the upper bits, 8-15 + clk, on the half-channel adapter. This is necessary to connect the clock in the system under test to the logic analyzer system clock.
- Using the E5386A does not reduce the performance of the 16760A logic analyzer and the soft touch probes.

If the E5386A is used in full-channel state mode, the thresholds on the unused (odd) bits are floating. This could result in spurious activity indicators in the format menu.



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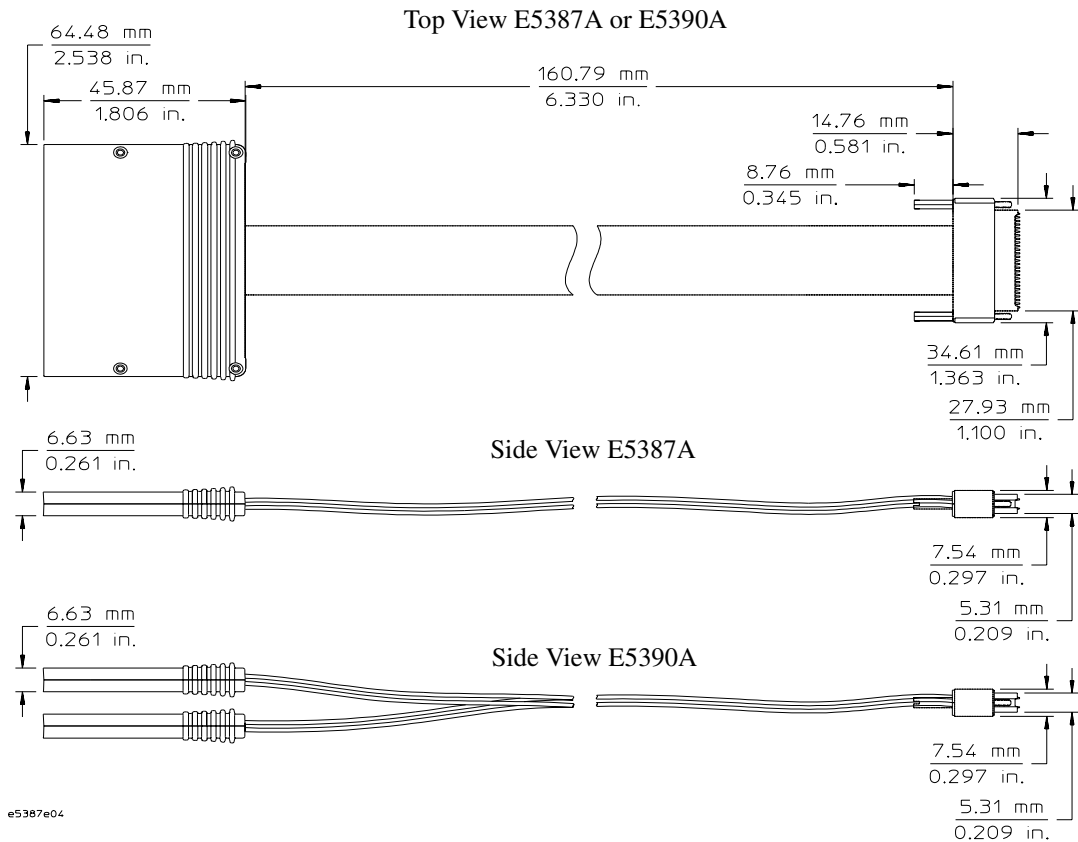
## Mechanical Considerations

Use the following mechanical information to design your target system board.

## E5387A and E5390A Soft Touch Probe Specifications

The following figures show dimensions, footprint, and pin-out information you will need to design your target system board for use with the Agilent E5387A and E5390A soft touch probes.

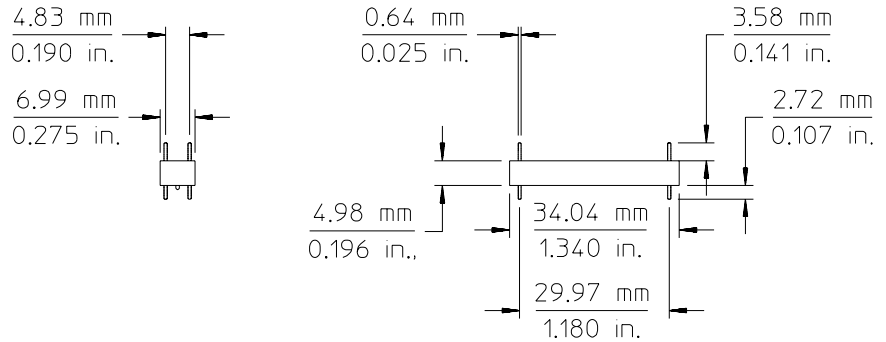
### Probe Dimensions





### Retention Module Dimensions

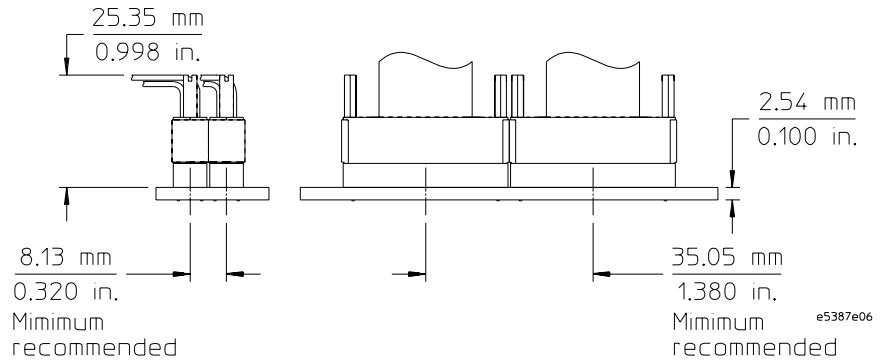
The soft touch probes are attached to the PC board using a retention module which ensures pin-to-pad alignment and holds the probe in place. A board thickness of up to 2.54 mm (0.100 in.) is recommended.



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### Probe and Retention Module Dimensions

The following dimensions show the soft touch probe attached to the retention module. The retention module is mounted on the PC board.

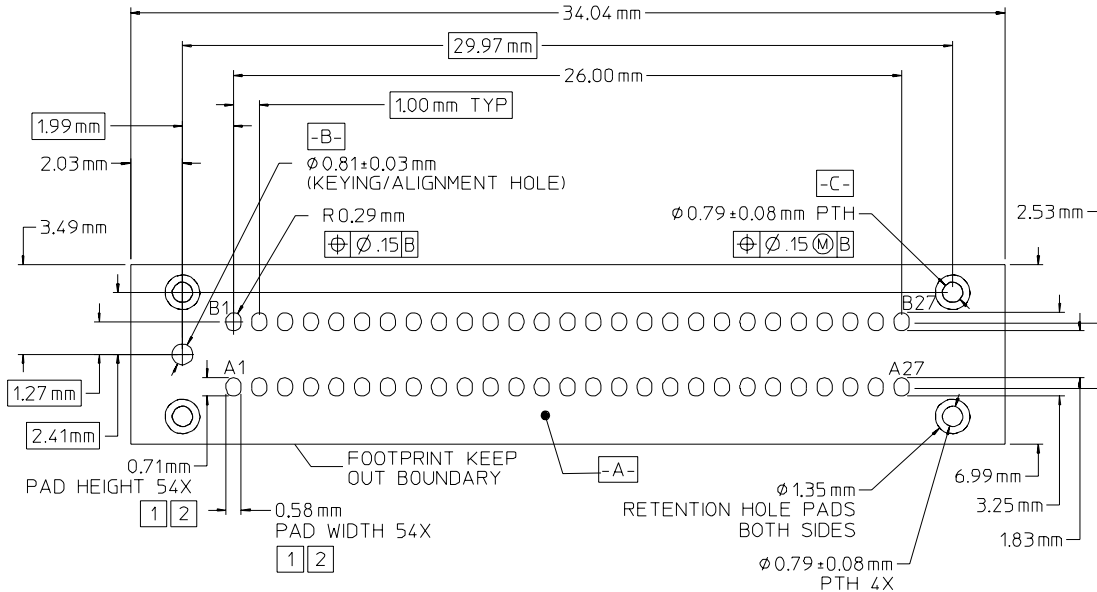


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Chapter 2: Mechanical Considerations  
**E5387A and E5390A Soft Touch Probe Specifications**

**Probe footprint dimensions**

Use this information to layout your PC board pads and holes for attaching the retention module.



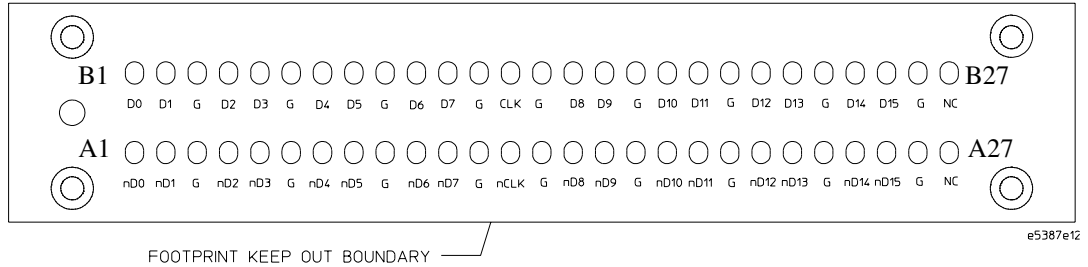
NOTES:

1. MUST MAINTAIN A SOLDER MASK WEB BETWEEN PADS WHEN TRACES ARE ROUTED BETWEEN THE PADS ON THE SAME LAYER. SOLDERMASK MAY NOT ENCROACH ONTO THE PADS WITHIN THE PAD DIMENSION SHOWN.
2. VIA IN PAD NOT ALLOWED ON THESE PADS. VIA EDGES MAY BE TANGENT TO PAD EDGES AS LONG AS A SOLDER MASK WEB BETWEEN VIAS AND PADS IS MAINTAINED.
3. PERMISSABLE SURFACE FINISHES ON PADS ARE HASL, IMMERSION SILVER, OR GOLD OVER NICKEL.
4. FOOTPRINT IS COMPATIBLE WITH RETENTION MODULE, AGILENT PART #E5387-68702.
5. RETENTION MODULE DIMENSIONS ARE 34.04 mm x 7.01 mm x 4.98 mm TALL RELATIVE TO THE TOP SURFACE OF THE PDB. RETENTION PINS EXTEND 4.32 mm BEYOND THE BOTTOM SURFACE OF THE RM THROUGH THE PCB.
6. ASSUME NORMAL ARTWORK TOLERANCES FOR PAD SIZE DIMENSIONS

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### Pin out for the E5387A differential soft touch

The following graphic and table show the E5387A differential soft touch probe pad numbers and logic analyzer pod inputs.



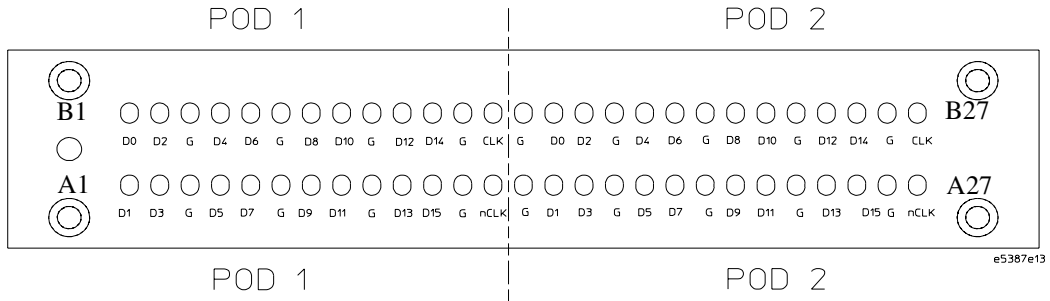
<b>E5387A Differential Soft Touch Probe Pin-out</b>			
<b>PAD#</b>	<b>Pod Input</b>	<b>PAD#</b>	<b>Pod Input</b>
A1	nD0 (-)	B1	D0 (+)
A2	nD1 (-)	B2	D1 (+)
A3	Ground	B3	Ground
A4	nD2 (-)	B4	D2 (+)
A5	nD3 (-)	B5	D3 (+)
A6	Ground	B6	Ground
A7	nD4 (-)	B7	D4 (+)
A8	nD5 (-)	B8	D5 (+)
A9	Ground	B9	Ground
A10	nD6 (-)	B10	D6 (+)
A11	nD7 (-)	B11	D7 (+)
A12	Ground	B12	Ground
A13	nCLOCK (-)	B13	CLOCK (+)
A14	Ground	B14	Ground
A15	nD8 (-)	B15	D8 (+)
A16	nD9 (-)	B16	D9 (+)
A17	Ground	B17	Ground
A18	nD10 (-)	B18	D10 (+)

**E5387A and E5390A Soft Touch Probe Specifications**

<b>E5387A Differential Soft Touch Probe Pin-out</b>			
<b>PAD#</b>	<b>Pod Input</b>	<b>PAD#</b>	<b>Pod Input</b>
A19	nD11 (-)	B19	D11 (+)
A20	Ground	B20	Ground
A21	nD12 (-)	B21	D12 (+)
A22	nD13 (-)	B22	D13 (+)
A23	Ground	B23	Ground
A24	nD14 (-)	B24	D14 (+)
A25	nD15 (-)	B25	D15 (+)
A26	Ground	B26	Ground
A27	N/C	B27	N/C

### Pin out for the E5390A single-ended soft touch probe

The following graphic and table show the E5390A single-ended soft touch probe pad numbers and logic analyzer pod inputs.



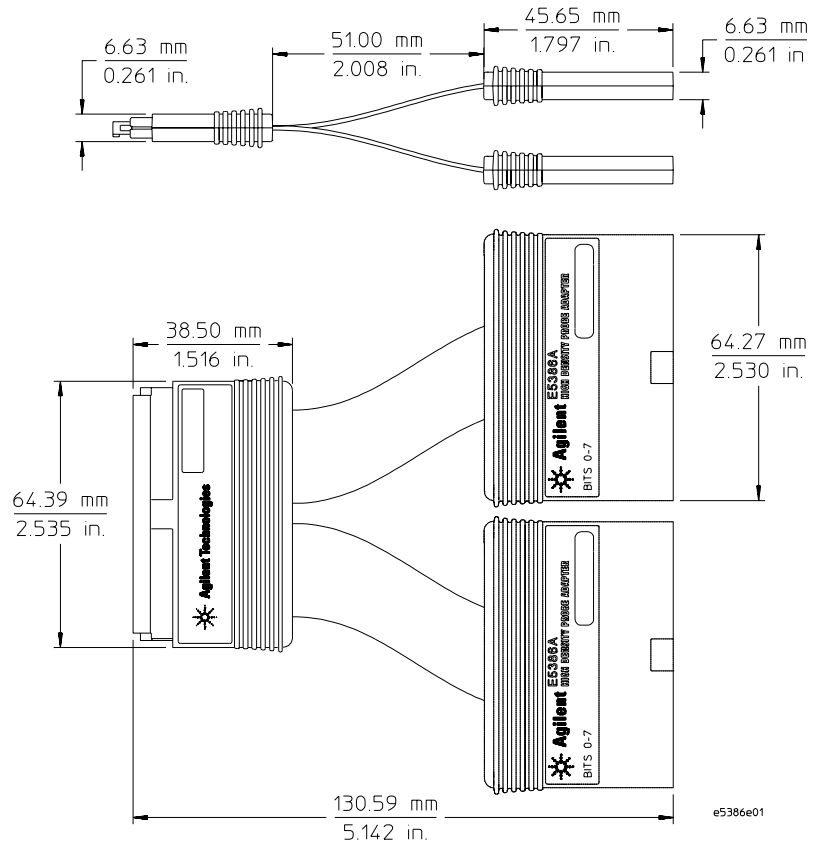
<b>E5390A Single-ended Soft Touch Probe Pin-out</b>			
<b>PAD#</b>	<b>Pod Input</b>	<b>PAD#</b>	<b>Pod Input</b>
A1	Odd D1	B1	Odd D0
A2	Odd D3	B2	Odd D2
A3	Ground	B3	Ground
A4	Odd D5	B4	Odd D4
A5	Odd D7	B5	Odd D6
A6	Ground	B6	Ground
A7	Odd D9	B7	Odd D8
A8	Odd D11	B8	Odd D10
A9	Ground	B9	Ground
A10	Odd D13	B10	Odd D12
A11	Odd D15	B11	Odd D14
A12	Ground	B12	Ground
A13	Odd CLK/D16N	B13	Odd CLKP/D16P
A14	Ground	B14	Ground
A15	Even D1	B15	Even D0
A16	Even D3	B16	Even D2
A17	Ground	B17	Ground

**E5387A and E5390A Soft Touch Probe Specifications**

<b>E5390A Single-ended Soft Touch Probe Pin-out</b>			
<b>PAD#</b>	<b>Pod Input</b>	<b>PAD#</b>	<b>Pod Input</b>
A18	Even D5	B18	Even D4
A19	Even D7	B19	Even D6
A20	Ground	B20	Ground
A21	Even D9	B21	Even D8
A22	Even D11	B22	Even D10
A23	Ground	B23	Ground
A24	Even D13	B24	Even D12
A25	Even D15	B25	Even D14
A26	Ground	B26	Ground
A27	Even CLKN/D16N	B27	Even CLKP/D16P

## E5386A Half-channel Adapter

The E5386A Half-channel Adapter works with the 16760A logic analyzer and the soft touch probes.



**Half-channel adapter dimensions.**

**E5386A Half-channel Adapter****E5386A used with E5387A Pin-out Table**

When used with the E5387A differential soft touch probe, you need only one half-channel adapter. The table below shows the pin assignments.

<b>E5386A Adapter</b>					
<b>E5387A Connector</b>				<b>Logic Analyzer</b>	
<b>Signal Name</b>	<b>Pin No.</b>	<b>Signal Name</b>	<b>Pin No.</b>	<b>Pod</b>	<b>Chan No.</b>
D0n	A1	D0p	B1	Pod 2	0
D1n	A2	D1p	B2	Pod 2	2
D2n	A4	D2p	B4	Pod 2	4
D3n	A5	D3p	B5	Pod 2	6
D4n	A7	D4p	B7	Pod 2	8
D5n	A8	D5p	B8	Pod 2	10
D6n	A10	D6p	B10	Pod 2	12
D7n	A11	D7p	B11	Pod 2	14
D8n	A15	D8p	B15	Pod 1	0
D9n	A16	D9p	B16	Pod 1	2
D10n	A18	D10p	B18	Pod 1	4
D11n	A19	D11p	B19	Pod 1	6
D12n	A21	D12p	B21	Pod 1	8
D13n	A22	D13p	B22	Pod 1	10
D14n	A24	D14p	B24	Pod 1	12
D15n	A25	D15p	B25	Pod 1	14
D16n/ClkN	A13	D16p/ClkP	B13	Pod 1	JCLKP



### E5386A used with E5390A Pin-out Table

When used with the E5390A single-ended soft touch probe, you need two half-channel adapters, one adapter for Odd data and one for Even data. The table below shows the pin assignments.

<b>E5386A Adapter #1</b>			
<b>E5390A Probe</b>		<b>Logic Analyzer</b>	
<b>Signal Name</b>	<b>Pin No.</b>	<b>Pod</b>	<b>Chan No</b>
Odd D0	B1	Pod 2	0
Odd D1	A1	Pod 2	2
Odd D2	B2	Pod 2	4
Odd D3	A2	Pod 2	6
Odd D4	B4	Pod 2	8
Odd D5	A4	Pod 2	10
Odd D6	B5	Pod 2	12
Odd D7	A5	Pod 2	14
Odd D8	B7	Pod 1	0
Odd D9	A7	Pod 1	2
Odd D10	B8	Pod 1	4
Odd D11	A8	Pod 1	6
Odd D12	B10	Pod 1	8
Odd D13	A10	Pod 1	10
Odd D14	B11	Pod 1	12
Odd D15	A11	Pod 1	14
Odd D16P/ClkP	B13	Pod 1	JCLK P
Odd D16N/ClkN	A13	Pod 1	JCLK N

<b>E5386A Adapter #2</b>			
<b>E5390A Probe</b>		<b>Logic Analyzer</b>	
<b>Signal Name</b>	<b>Pin No.</b>	<b>Pod</b>	<b>Chan No.</b>
EvN D0	B15	Pod 2	0
EvN D1	A15	Pod 2	2
EvN D2	B16	Pod 2	4
EvN D3	A16	Pod 2	6
EvN D4	B18	Pod 2	8
EvN D5	A18	Pod 2	10
EvN D6	B19	Pod 2	12
EvN D7	A19	Pod 2	14
EvN D8	B21	Pod 1	0
EvN D9	A21	Pod 1	2
EvN D10	B22	Pod 1	4
EvN D11	A22	Pod 1	6
EvN D12	B24	Pod 1	8
EvN D13	A24	Pod 1	10
EvN D14	B25	Pod 1	12
EvN D15	A25	Pod 1	14
EvN D16P/ClkP	B27	Pod 1	JCLK P
EvN D16N/ClkN	A27	Pod 1	JCLK N



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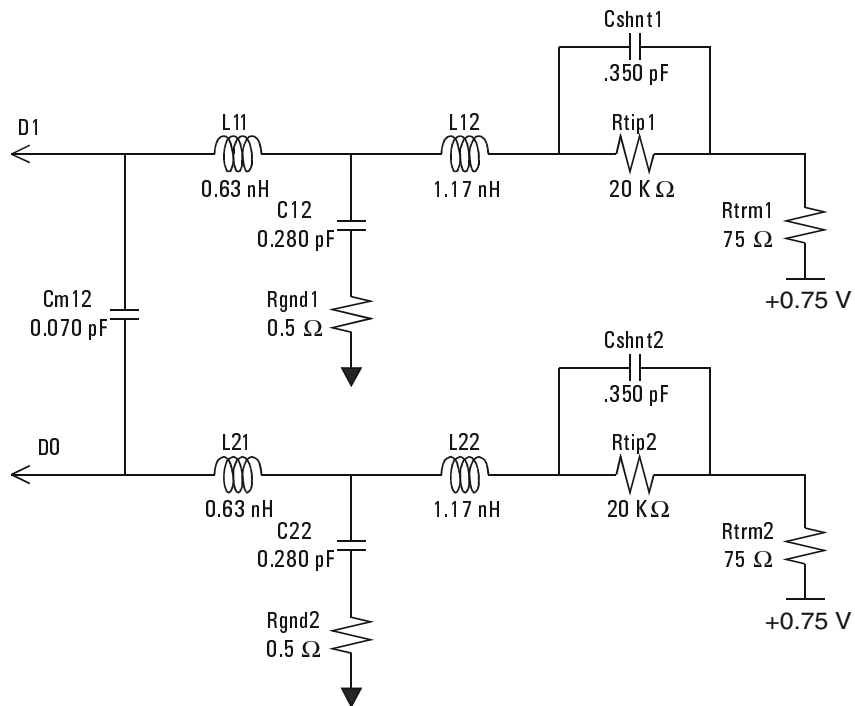
## Operating the Probe

Electrical considerations such as equivalent probe loads, input impedance, time domain transmission (TDT), step inputs, and eye opening.

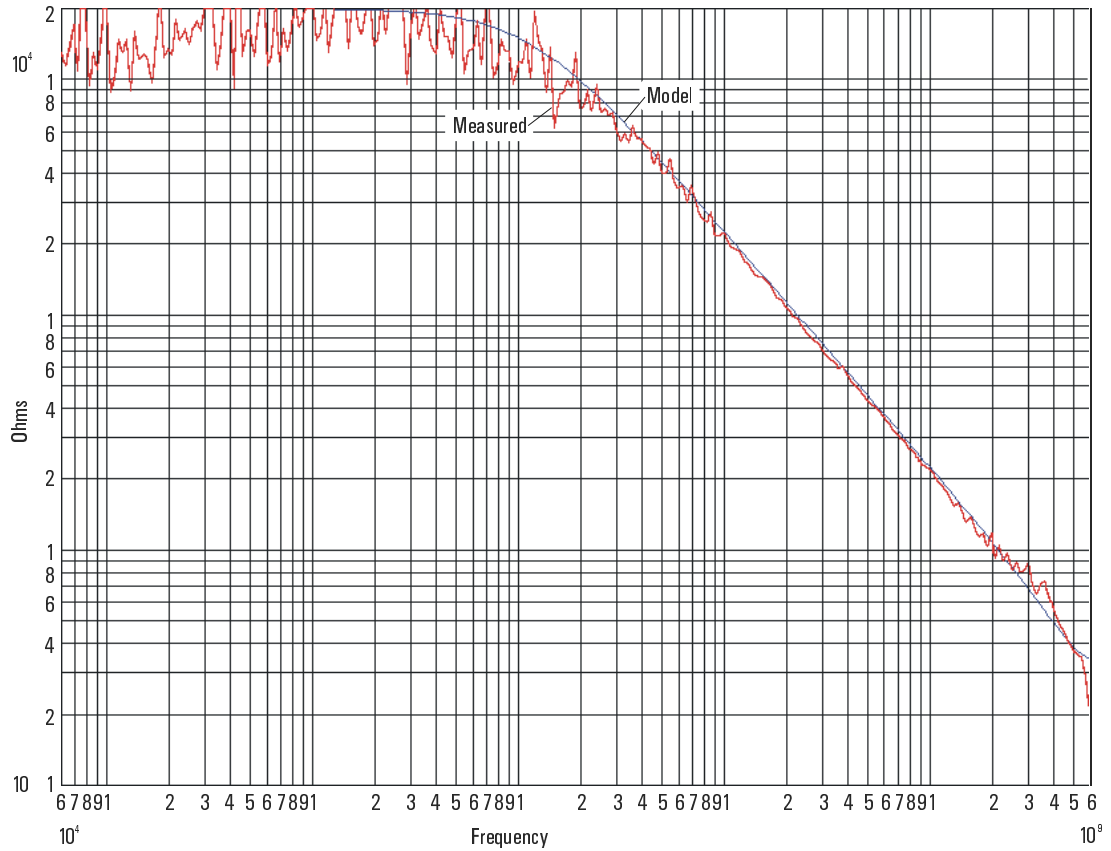
## Equivalent Probe Loads

The following probe load models are based on in-circuit measurements made with an Agilent 8753E 6 GHz network analyzer and an Agilent 54750A TDR/TDT using a  $50\ \Omega$  test fixture. The following schematic accurately models the probe load out to 6 GHz. The figure on the following page shows the agreement between measured impedance and this model. PC board pads are not included.

### E5387A and E5390A probe load model



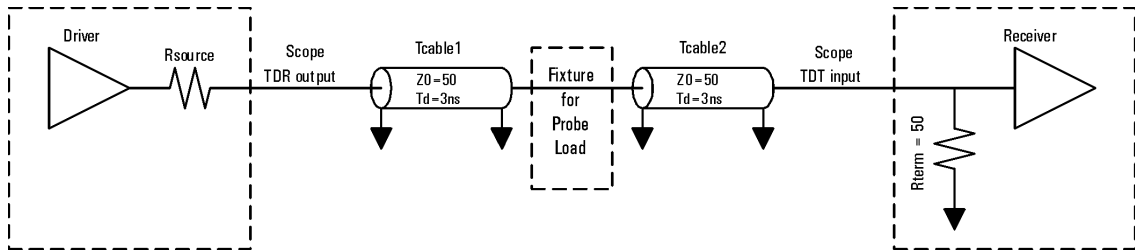
### Measured versus modeled input impedance



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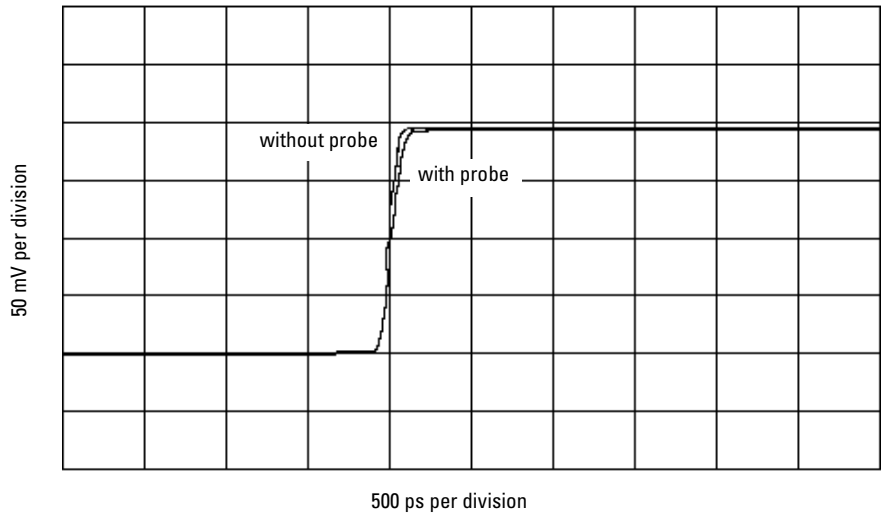
## Time Domain Transmission (TDT)

All probes have a loading effect on the circuit when they come in contact with the circuit. Time domain transmission (TDT) measurements are useful for understanding the probe loading effects as seen at the target receiver. The following TDT measurements were made mid-bus on a  $50\Omega$  transmission line load terminated at the receiver. These measurements show how the E5387A and E5390A soft touch probes affect an ideal step seen by the receiver for various rise times.

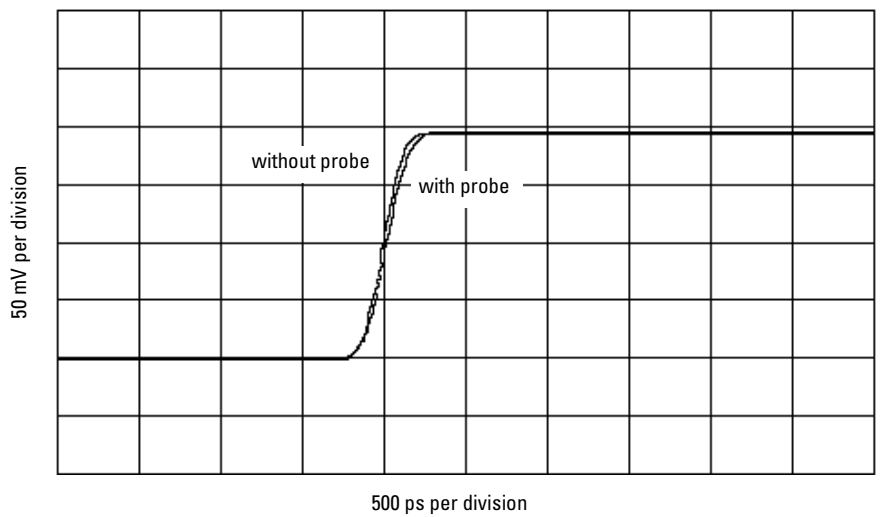


**TDT measurement schematic**

The following plots were made on an Agilent 54750A oscilloscope using TDT.

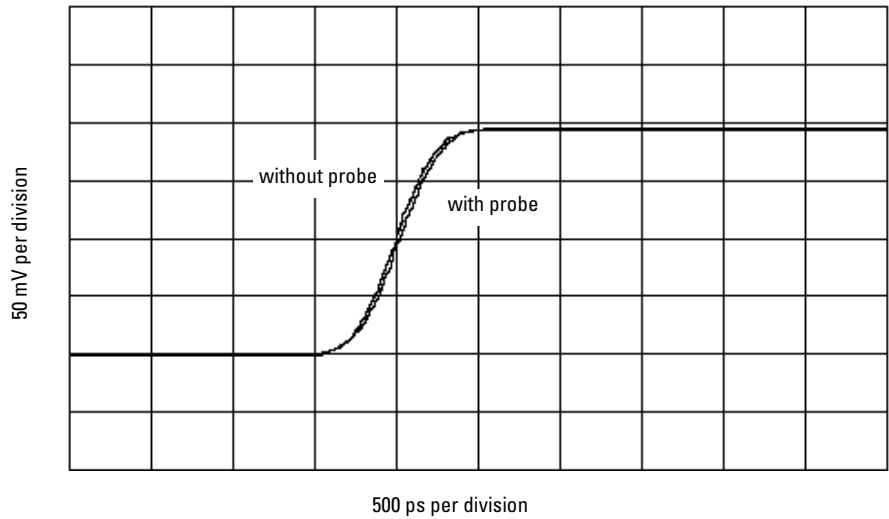


**TDT measurement at receiver with and without probe load for 100 ps rise time**

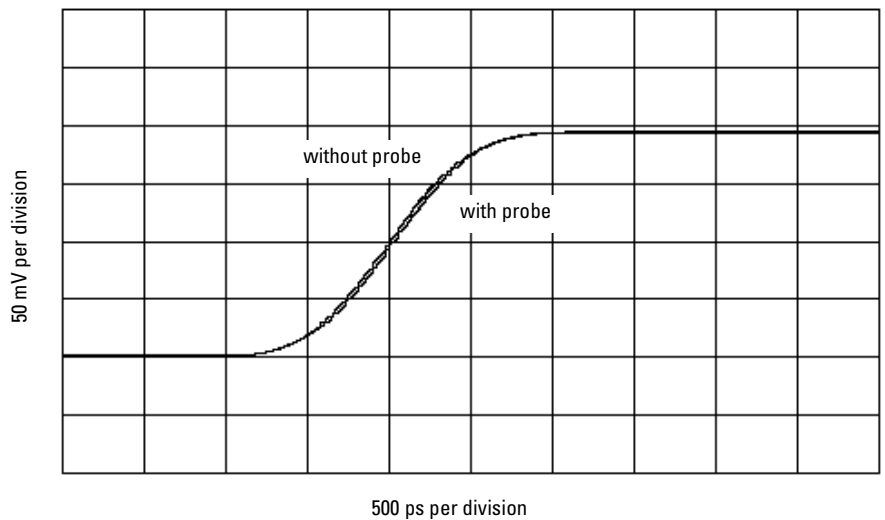


**TDT measurement at receiver with and without probe load for 250 ps rise time**

Chapter 3: Operating the Probe  
**Time Domain Transmission (TDT)**



**TDT measurement at receiver with and without probe load for 500 ps rise time**

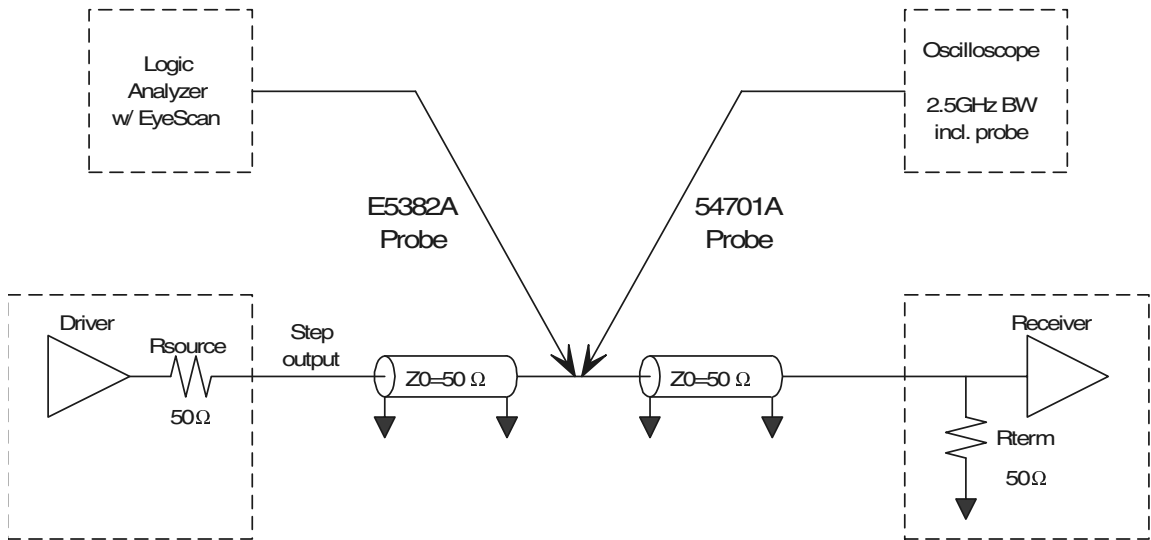


**TDT measurement at receiver with and without probe load for 1000 ps rise time**



## Step Inputs

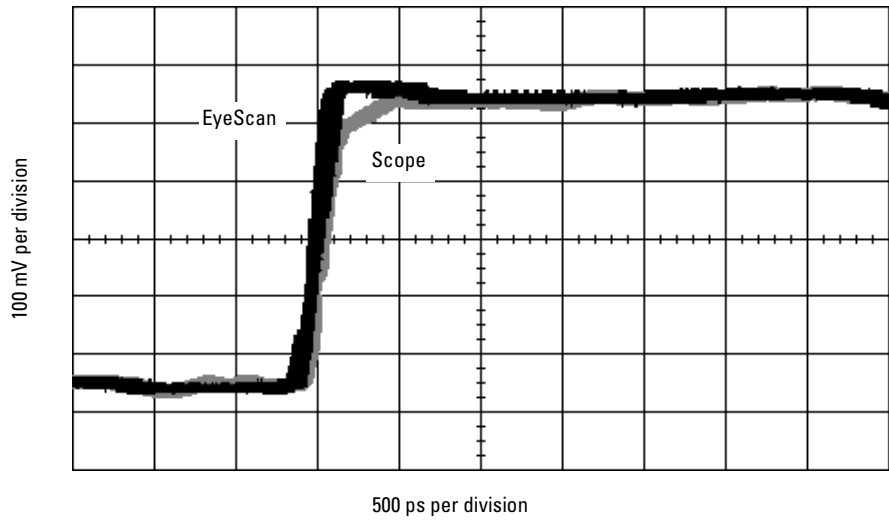
Maintaining signal fidelity to the logic analyzer is critical if the analyzer is to accurately capture data. One measure of a system's signal fidelity is to compare  $V_{in}$  to  $V_{out}$  for various step inputs. For the following graphs,  $V_{in}$  is the signal at the logic analyzer probe tip. Eye Scan was used to measure  $V_{out}$ , the signal seen by the logic analyzer. The measurements were made on a mid-bus connection to a  $50\Omega$  transmission line load terminated at the receiver. These measurements show the logic analyzer's response while using the E5387A and E5390A soft touch probes.



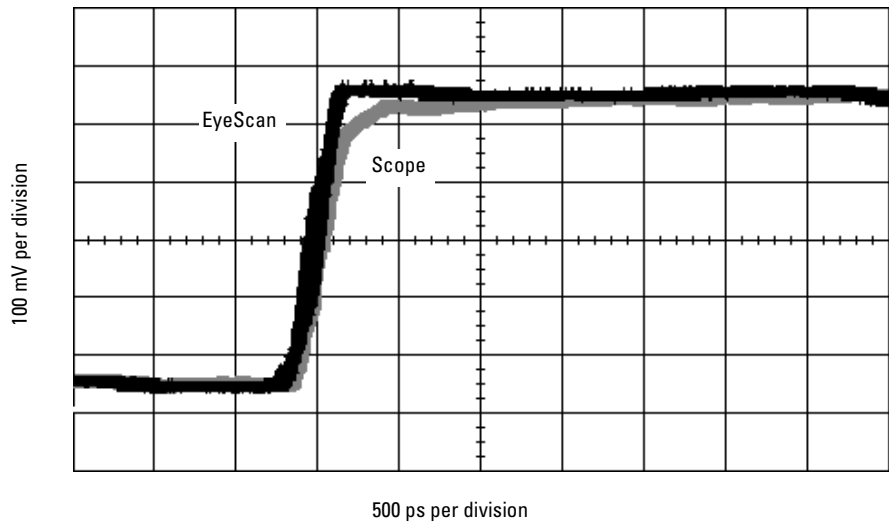
### Step input measurement schematic

The following plots were made on an Agilent 54750A oscilloscope and an Agilent 16760A logic analyzer using an Agilent 8133A pulse generator with various rise time converters.

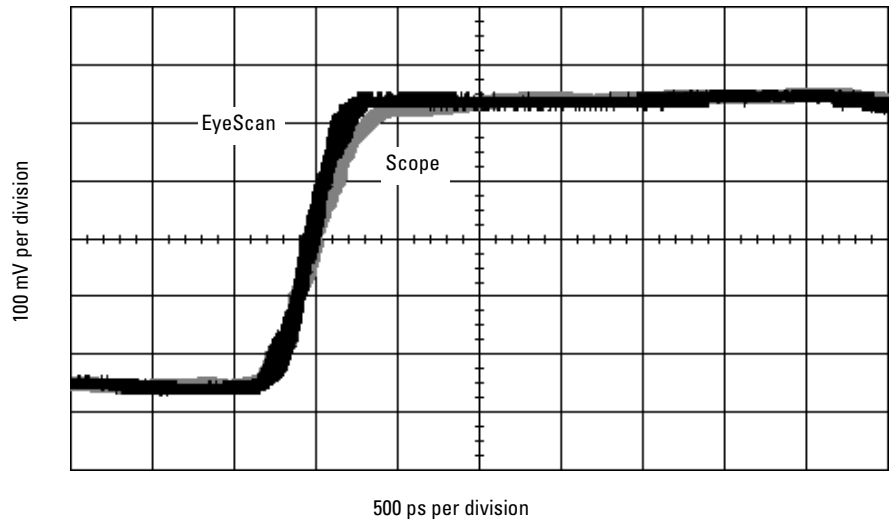
Chapter 3: Operating the Probe  
**Step Inputs**



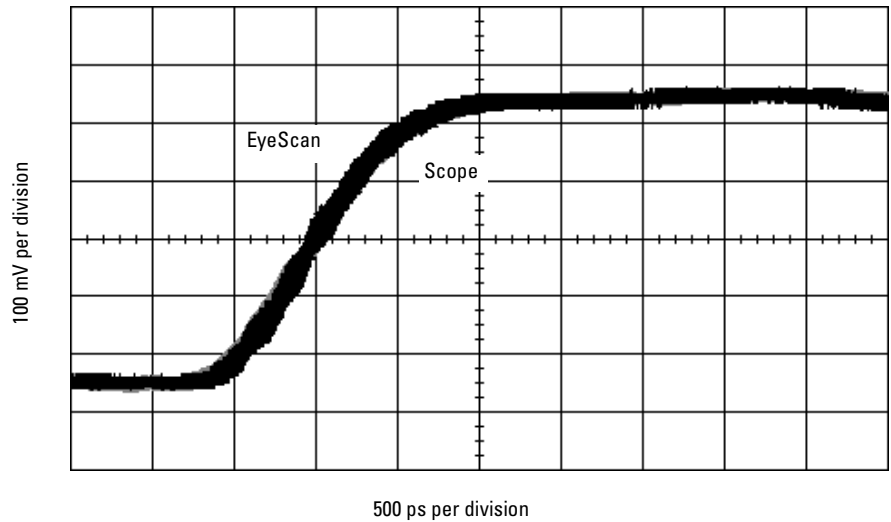
**Logic analyzer's response to 150 ps rise time**



**Logic analyzer's response to 250 ps rise time**



**Logic analyzer's response to 500 ps rise time**

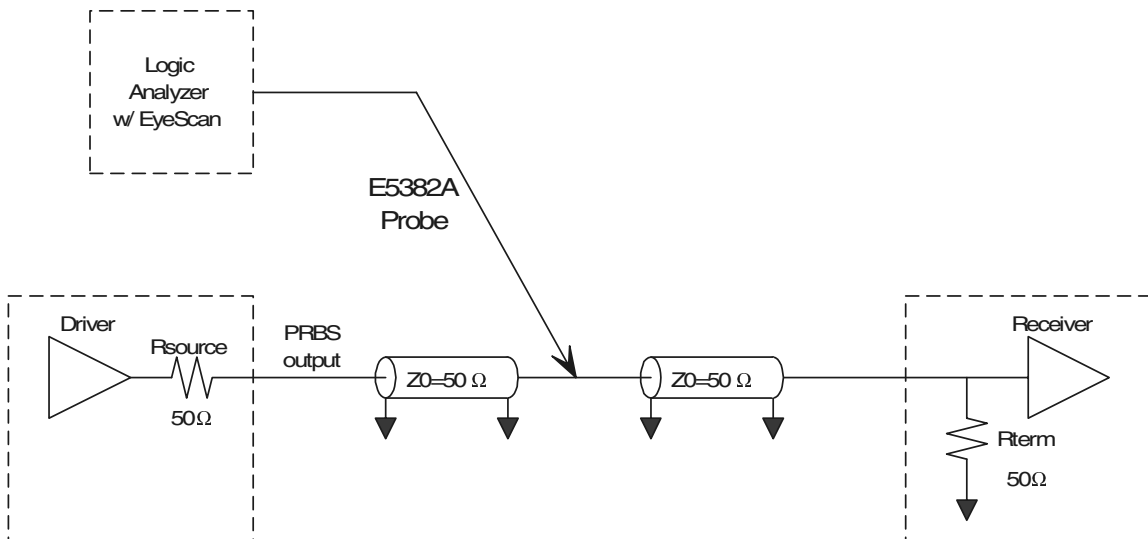


**Logic analyzer's response to 1000 ps rise time**

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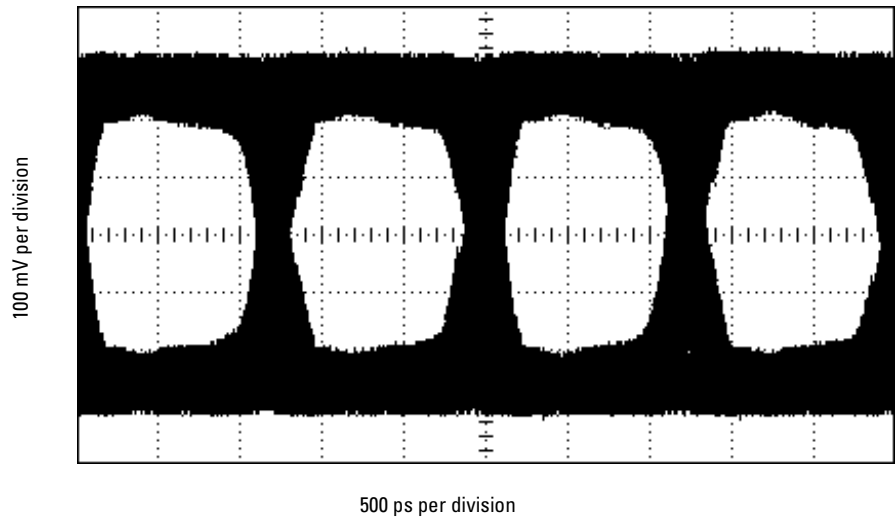
## Eye Opening

The eye opening at the logic analyzer is the truest measure of an analyzer's ability to accurately capture data. Seeing the eye opening at the logic analyzer is possible with Eye Scan. The eye opening viewed with Eye Scan helps the user know how much margin the logic analyzer has, where to sample and at what threshold. Any probe response that exhibits overshoot, ringing, probe non-flatness, noise, and other issues all deteriorate the eye opening seen by the logic analyzer. The following eye diagrams were measured using E5387A and E5390A soft touch probes and Eye Scan while probed mid-bus on a 50Ω transmission line load terminated at the receiver. The data patterns were generated using a  $2^{23}-1$  pseudo random bit sequence (PRBS).

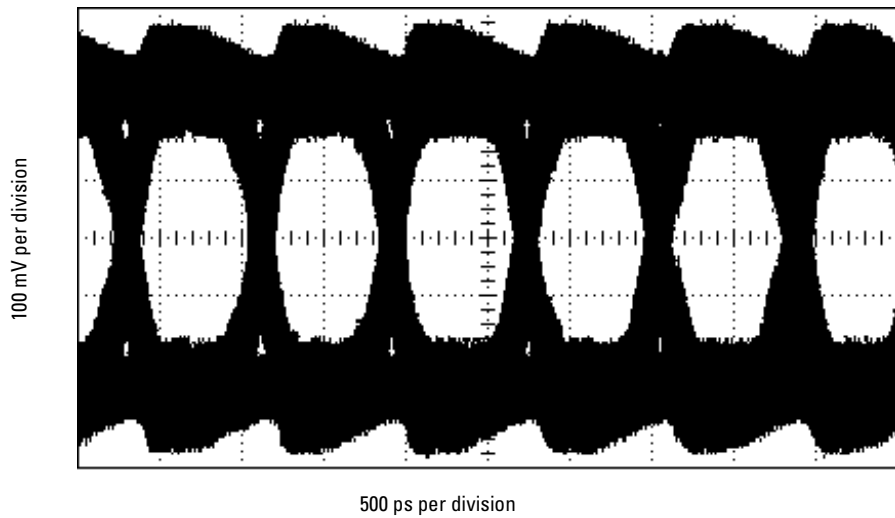


### Eye opening measurement schematic

The following plots were made on an Agilent 16760A logic analyzer using an Agilent 8133A pulse generator with a 250 ps rise time converter. The following measurements use Eye Scan to show the margin at 800, 1250, and 1500MT/s. The amplitudes are indicated in the captions.

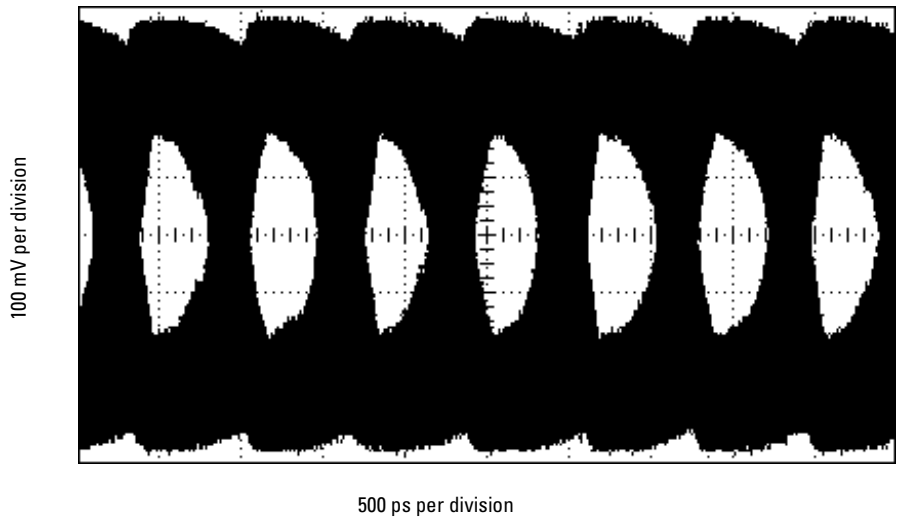


**Logic analyzer eye opening for a PRBS signal of 500 mV p-p, 800 MT/s data rate**

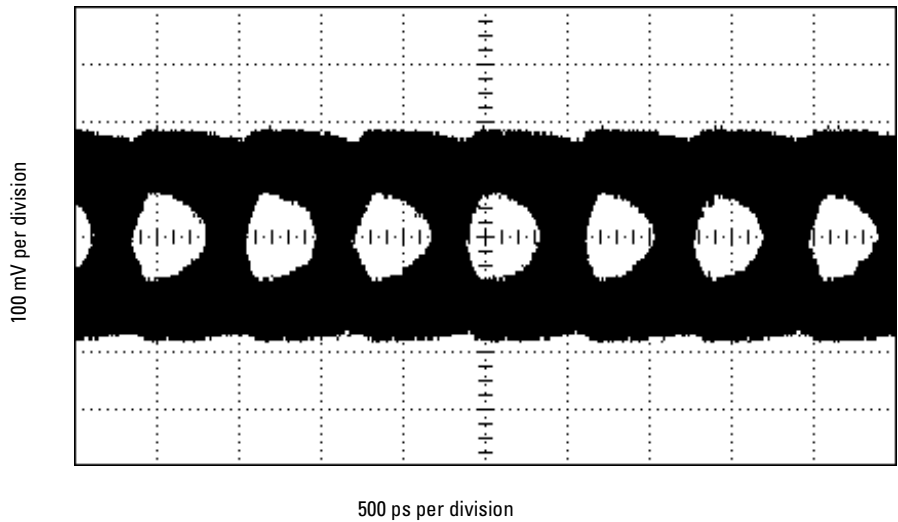


**Logic analyzer eye opening for a PRBS signal of 500 mV p-p, 1250 MT/s data rate**

Chapter 3: Operating the Probe  
**Eye Opening**



**Logic analyzer eye opening for a PRBS signal of 500 mV p-p, 1500 MT/s data rate**



**Logic analyzer eye opening for a PRBS signal of 200 mV p-p, 1500 MT/s data rate**

---

## Circuit Board Design

Design considerations when you layout your circuit board.

## Transmission Line Considerations

Stubs connecting signal transmission lines to the connector should be as short as feasible. Longer stubs will cause more loading and reflections on a transmission line. If the electrical length of a stub is less than 1/5 of the signal rise time, it can be modeled as a lumped capacitance. Longer stubs must be treated as transmission lines.

---

**Example:**

Assume you are using FR-4 PC board material with a dielectric constant of  $\sim 4.3$  for inner-layer traces (stripline). For example, A 0.28 cm long stub in an inner layer has a propagation delay of  $\sim 20$  ps. Therefore, for a signal with a rise time of 100 ps or greater, a 0.28 cm stub will behave like a capacitor.

The trace capacitance per unit length will depend on the trace width and the spacing to ground or power planes. If the trace is laid out to have a characteristic impedance of  $50 \Omega$  it turns out that the capacitance per unit length is  $\sim 1.2$  pF/cm. Therefore the 0.28 cm stub in the previous example would have an effective capacitance equal to  $\sim 0.34$  pF.

---

This trace capacitance is in addition to the probe load model.

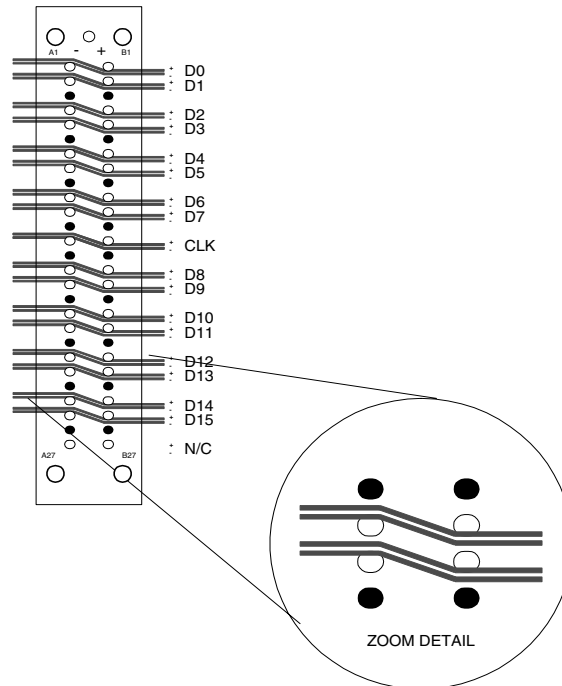


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## Recommended Routing

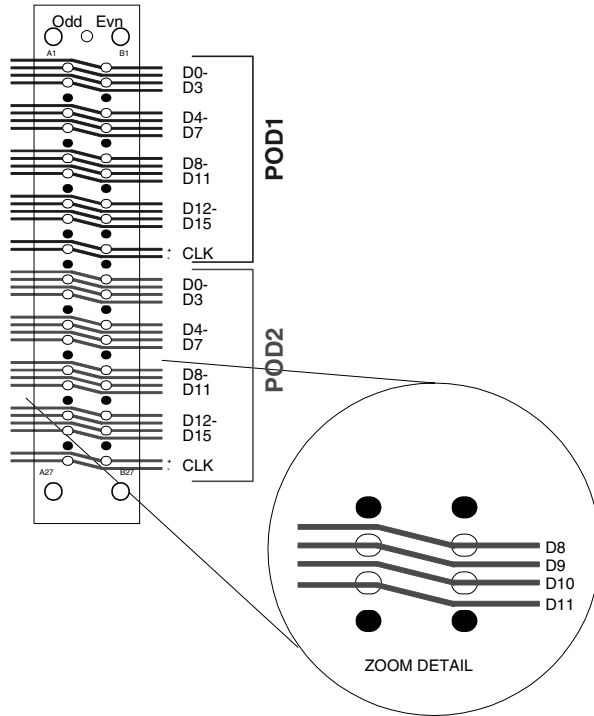
Two rows of compliant contacts in the probe make contact with pads laid down on the surface of the PC board. These contacts provide an extremely low probe load (<0.70 pF per channel), and make a good electrical connection with a small amount of compression force on a choice of standard PCB platings. Additionally, the pin contact points are free from the contamination effects that plague other connector-less probing technologies.

### Agilent E5387A 17-bit routing



**Recommended Routing**

**Agilent E5390A 34-bit routing**



## Data and Clock Inputs per Operating Mode

The following table shows the number of data and clock inputs for each connector on your target system for the various operating modes of your logic analyzer.

### 16760A logic analyzer

Operating Mode	E5387A differential soft touch	E5387A with half-channel adapter E5386A	E5390A single-ended soft touch	E5390A with half-channel adapter E5386A
<b>Synchronous (state) analysis</b> 200 Mb/s, 400 Mb/s, 800 Mb/s	16 data plus 1 clock input (see note 1)	N/A	32 data plus 2 clock inputs (see note 1)	N/A
<b>Synchronous (state) analysis</b> 1250 Mb/s 1500 Mb/s	8 data plus 1 clock input (see note 2)	16 data plus 1 clock input (see note 2)	16 data plus 1 clock input (see note 2)	32 data plus 1 clock input (see note 2)
<b>Eye scan mode</b> 800 Mb/s	16 data plus 1 clock input (see note 1)	N/A	32 data plus 2 clock inputs (see note 1)	N/A
<b>Eye scan mode</b> 1500 Mb/s	8 data plus 1 clock input (see note 2)	16 data plus 1 clock input (see note 2)	16 data plus 1 clock input (see note 2)	32 data plus 1 clock input (see note 2)
<b>Timing mode</b>	16 data plus 1 clock input (see note 3)	N/A	32 data plus 2 clock inputs (see note 3)	N/A

Note 1: In the 200 Mb/s, 400 Mb/s, and 800 Mb/s synchronous (state) analysis modes, and the 800 Mb/s eye scan mode, there is one clock input which must be routed to the clock input on pod 1 (of the master module, in a multi-card set). The clock inputs on other pods can be assigned to labels and acquired as data inputs.

Note 2: In the 1250 Mb/s and 1500 Mb/s synchronous (state) analysis

**Data and Clock Inputs per Operating Mode**

modes, and in the 1500 Mb/s eye scan mode, the clock inputs on other pods cannot be assigned to labels and acquired as data inputs.

Note 3: In asynchronous (timing) analysis, all inputs including clocks can be acquired and assigned to labels.

- To realize 17 data inputs (in full-channel mode) while using time tags in addition to a clock input on a single 16760A module or on the master module in a multi-card set, you must route the data signals to pod 2 and the clock to pod 1. A convenient way to avoid laying out a second connector to connect only the clock signal is to use the Agilent E5382A flying-lead set to make the connection to the clock.

- To use the qualifier input for eye scan, the qualifier signal must be routed to the clock input on pad 2 (K clock), and the clock must be routed to the clock input on pod 1 (J clock), each on the master module in case of a multi-card set.

- In a multiple-card set, the clock used for synchronous (state) analysis must be routed to the clock input on pod 1 of the master module. On a single card, the clock must be routed to the clock input on pod 1.

**16753/54/55/56A logic analyzers**

Operating Mode	E5387A differential soft touch	E5387A with half-channel adapter E5386A	E5390A single-ended soft touch	E5390A with half-channel adapter E5386A
<b>Synchronous (state) analysis</b> 300 Mb/s, 600 Mb/s,	16 data plus 1 clock input (see note 1)	N/A	32 data plus 2 clock inputs (see note 1)	N/A
<b>Eye scan mode</b> 300 Mb/s 600 Mb/s	16 data plus 1 clock input (see note 1)	N/A	32 data plus 2 clock inputs (see note 1)	N/A
<b>Timing mode</b>	16 data plus 1 clock input (see note 1)	N/A	32 data plus 2 clock inputs (see note 3)	N/A

Note 1: In 600 Mb/s mode, there is one clock input which must be routed to the clock input on pod 1 of the master module in a multi-card set. The clock inputs on the other pods can be assigned to labels and acquired as data inputs.

---

## Thresholds

### E5387A differential soft touch probe

#### Data inputs

If you are using the E5387A differential soft touch probe to acquire differential signals, you would normally allow the logic analyzer to discriminate between high and low states based on the crossover of the data and  $\overline{\text{data}}$  inputs.

You may also use the E5387A differential probe to acquire single-ended signals. If you are using the E5387A probe to acquire single-ended signals, you should either ground the  $\overline{\text{data}}$  inputs or connect them to a dc power supply. You may:

- Ground the  $\overline{\text{data}}$  inputs and adjust the threshold in the user interface.

Or

- Supply a threshold reference voltage to the  $\overline{\text{data}}$  inputs. In this case, the threshold in the user interface should be set to zero.

If your circuit uses a resistive divider to provide a threshold reference, make sure the thevenin equivalent resistance is around 50  $\Omega$ .

---

**NOTE:**

---

The threshold can only be changed on a per pod basis.

#### Clock input

The same choices exist for the clock input on the E5387A differential probe as outlined above for the data inputs. The clock input has a separate, independent threshold adjustment.

### E5390A single-ended soft touch probe

#### Data inputs

The E5390A single-ended soft touch probe has two inputs for a user-supplied threshold voltage for the data inputs, one for the even pod and one for the odd pod. The threshold inputs (pins 87 and 88) may be grounded, left open, or connected to a dc power supply. For each group of data inputs, you may either:

- Supply a threshold voltage between -3V dc and +5V dc to the threshold input.

## Thresholds

The logic analyzer will use this threshold to determine when the signal is high or low.

Or

- Adjust the logic threshold in the user interface to between -3V dc and +5V dc.

The advantages of supplying a threshold voltage via the threshold input on the probe are:

- A threshold supplied from the source will typically track changes in supply voltage, temperature, etc.
- A threshold supplied from the target is typically the same threshold that the target system's logic uses to evaluate the signals. Therefore the data captured by the logic analyzer will be congruent with the data as interpreted by the target system.

## Clock input

The clock input to the E5390A probe is differential. If you supply a differential clock, you should select the "differential" option in the clock threshold user interface.

If your system uses a single-ended clock signal, the  $\overline{\text{clock}}$  input should be either grounded or connected to a dc power supply. You may:

- Ground the  $\overline{\text{clock}}$  input and adjust the clock threshold from the user interface to between -3V dc and +5V dc.

Or

- Supply a threshold reference voltage between -3V dc and +5V dc to the  $\overline{\text{clock}}$  input. In this case, the clock threshold in the user interface should be set to zero.

If your circuit uses a resistive divider to provide a threshold reference, make sure the thevenin equivalent resistance is around 50  $\Omega$

The threshold for the clock input has a separate adjustment in the user interface, independent of the data inputs.

---

## Signal Access

### **Labels split across probes**

If a label is split across more than one pod, this leads to restrictions in triggering. Refer to "Triggering with the Agilent 1675x and 1676x" (Agilent publication number 5988-2994EN) for more details.

### **Reordered bits**

If bits need to be reordered within a label, this leads to additional restrictions in triggering. Specifically, equalities can be used to evaluate the value of a label with reordered bits, but inequalities cannot be used. You may be able to avoid the need to reorder bits in a label by routing signals to appropriate pins on the probe connector. Refer to "Triggering with the Agilent 1675x and 1676x" (Agilent publication number 5988-2994EN) for more details.

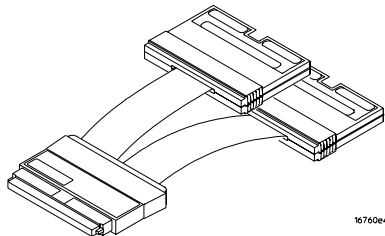
**Thresholds****Half-channel 1.25 and 1.5 Gb/s modes (16760A only)**

In the half-channel 1.25 and 1.5 Gb/s modes, the 16760A analyzer accesses only the even channels (0,2,4, etc.). In the Format user interface, the connections within a pod (16-signal group) are mapped as follows:

Connector pins	Connection name in this document (pages 19- 21)	Reference in format window
7,8	D0	Bit0
15,16	D2	Bit1
23,24	D4	Bit2
31,32	D6	Bit3
39,40	D8	Bit4
47,48	D10	Bit5
55,56	D12	Bit6
63,64	D14	Bit7

Note that in the 1.25 and 1.5 Gb/s half-channel mode, the clock inputs cannot be assigned as bits in a label.

**E5386A Half-channel Adapter.** The E5386A can be used with the E5387A differential soft touch probe or the E5390A single-ended probe to map the signals from the PC board pads to the 16760A when operating in half-channel state mode.





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## Recommended Reading

A list of recommended reading for more information about systems and high-speed digital design.

## For More Information

For more information on Agilent logic analyzers, refer to <http://www.agilent.com/find/logicanalyzer>. For more information on your specific analyzer, refer to the online help in the product.

## MECL System Design Handbook

Blood, William R. Jr., "MECL System Design Handbook," 4th edition, 1988, published by Motorola. This handbook can be obtained from ON Semiconductor on the web. Go to <<http://onsemi.com>>. Click on "On-line ordering" under "Documentation." Click on the link "General search." Type in "HB205" in the "Document number" field. Click "Submit." To view the document online, click on "PDF" in the right-hand column titled "PDF MFAX." Or order a hardcopy of the handbook on-line.

## High-speed Digital Design

Johnson, Howard W., and Martin Graham, "High-speed Digital Design," Prentice-Hall, 1993, ISBN 0-13-395724-1

## Designing High-speed Target Systems for Logic Analyzer Probing

"Designing High-speed Target Systems for Logic Analyzer Probing" Agilent Technologies application note publication number 5988-2989EN.

## A

adapter, E5386A half-channel, 13

## C

circuit board design, 39  
cleaning the instrument, 53  
clock inputs, 43  
    E5387A, 45  
    E5390A, 45

## D

data inputs, 43  
    E5387A, 45  
    E5390A, 45  
design theory, 39  
differential input amplitude  
    definition, 11  
differential probe, 11  
dimensions  
    half-channel adapter, 23  
    probe and retention module, 17  
    retention module, 17  
    soft touch probes, 16

## E

E5386A half-channel adapter, 13  
E5387A differential soft touch  
    probe, 11  
E5390A single-ended soft touch  
    probe, 12  
electrical considerations, 27  
equivalent probe loads, 28  
eye scan, 43

## F

footprint, 18

## H

half-channel adapter, 13, 23  
half-channel mode, 48

## I

instrument, cleaning the, 53

## K

keep-out area, 18

## L

labels, 47

## M

mechanical considerations, 15

## N

number of probes required, 10

## O

operating mode, 43  
ordering retention modules, 10

## P

pinout  
    E5386A used with E5387A, 24  
    E5386A used with E5390A, 25  
    E5387A differential probe and  
        logic analyzer, 19  
    E5390 single-ended soft touch  
        and logic analyzer, 21  
probe  
    E5387A differential soft touch,  
        11  
    E5390A single-ended soft touch,  
        12  
    footprint dimensions, 18  
    number required, 10  
    state speed, 10  
probing options, 9

## R

recommended reading, 49  
reordered bits, 47

required number of probes, 10  
retention module dimensions, 17  
retention module footprint, 18  
retention modules, ordering, 10  
routing, 41

## S

signal access, 47  
single-ended probe, 12  
soft touch probe dimensions, 16  
specifications  
    E5386A Half-channel Adapter,  
        23  
    soft touch probes, 16  
state speed supported, 10  
supported state speed, 10  
synchronous state analysis, 43

## T

thresholds, 45  
transmission line considerations,  
    40



# Safety Notices

This apparatus has been designed and tested in accordance with IEC Publication 1010, Safety Requirements for Measuring Apparatus, and has been supplied in a safe condition. This is a Safety Class I instrument (provided with terminal for protective earthing). Before applying power, verify that the correct safety precautions are taken (see the following warnings). In addition, note the external markings on the instrument that are described under "Safety Symbols."

## Warnings

- Before turning on the instrument, you must connect the protective earth terminal of the instrument to the protective conductor of the (mains) power cord. The mains plug shall only be inserted in a socket outlet provided with a protective earth contact. You must not negate the protective action by using an extension cord (power cable) without a protective conductor (grounding). Grounding one conductor of a two-conductor outlet is not sufficient protection.
- Only fuses with the required rated current, voltage, and specified type (normal blow, time delay, etc.) should be used. Do not use repaired fuses or short-circuited fuseholders. To do so could cause a shock or fire hazard.
- If you energize this instrument by an auto transformer (for voltage reduction or mains isolation), the common terminal must be connected to the earth terminal of the power source.
- Whenever it is likely that the

ground protection is impaired, you must make the instrument inoperative and secure it against any unintended operation.

- Service instructions are for trained service personnel. To avoid dangerous electric shock, do not perform any service unless qualified to do so. Do not attempt internal service or adjustment unless another person, capable of rendering first aid and resuscitation, is present.
- Do not install substitute parts or perform any unauthorized modification to the instrument.
- Capacitors inside the instrument may retain a charge even if the instrument is disconnected from its source of supply.
- Do not operate the instrument in the presence of flammable gasses or fumes. Operation of any electrical instrument in such an environment constitutes a definite safety hazard.
- Do not use the instrument in a manner not specified by the manufacturer.

## To clean the instrument

If the instrument requires cleaning: (1) Remove power from the instrument. (2) Clean the external surfaces of the instrument with a soft cloth dampened with a mixture of mild detergent and water. (3) Make sure that the instrument is completely dry before reconnecting it to a power source.

## Safety Symbols



Instruction manual symbol: the product is marked with this symbol when it is necessary for you to refer to the instruction manual in order to protect against damage to the product..



Hazardous voltage symbol.



Earth terminal symbol: Used to indicate a circuit common connected to grounded chassis.

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